


<b>Search Notes</b>  	<b>Application/Control No.</b>  10735698	<b>Applicant(s)/Patent Under Reexamination</b>  LEE, SANG-CHUL
	<b>Examiner</b>  HOAN C NGUYEN	<b>Art Unit</b>  2871

SEARCHED			
Class	Subclass	Date	Examiner
349	58, 149, 150, 152	7/8/08	chn
361	681	7/8/08	chn

SEARCH NOTES		
Search Notes	Date	Examiner
East search in US-PGPUB, USPAT, EPO, JPO, Derwent and IBM_TDB	7/8/08	chn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	All subclasses above and TEXT search	7/8/08	chn